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(12) **United States Design Patent**
Chang

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(54) **CLAMP MULTIMETER**

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(**) Term: **14 Years**

(21) Appl. No.: **29/229,113**

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(51) **LOC (8) Cl.** **10-04**

(52) **U.S. Cl.** **D10/79**

(58) **Field of Classification Search** D10/78,
D10/79; 324/72.5, 110, 114, 115, 149, 151 A,
324/151 R, 156, 158 F, 126-130, 158 P
See application file for complete search history.

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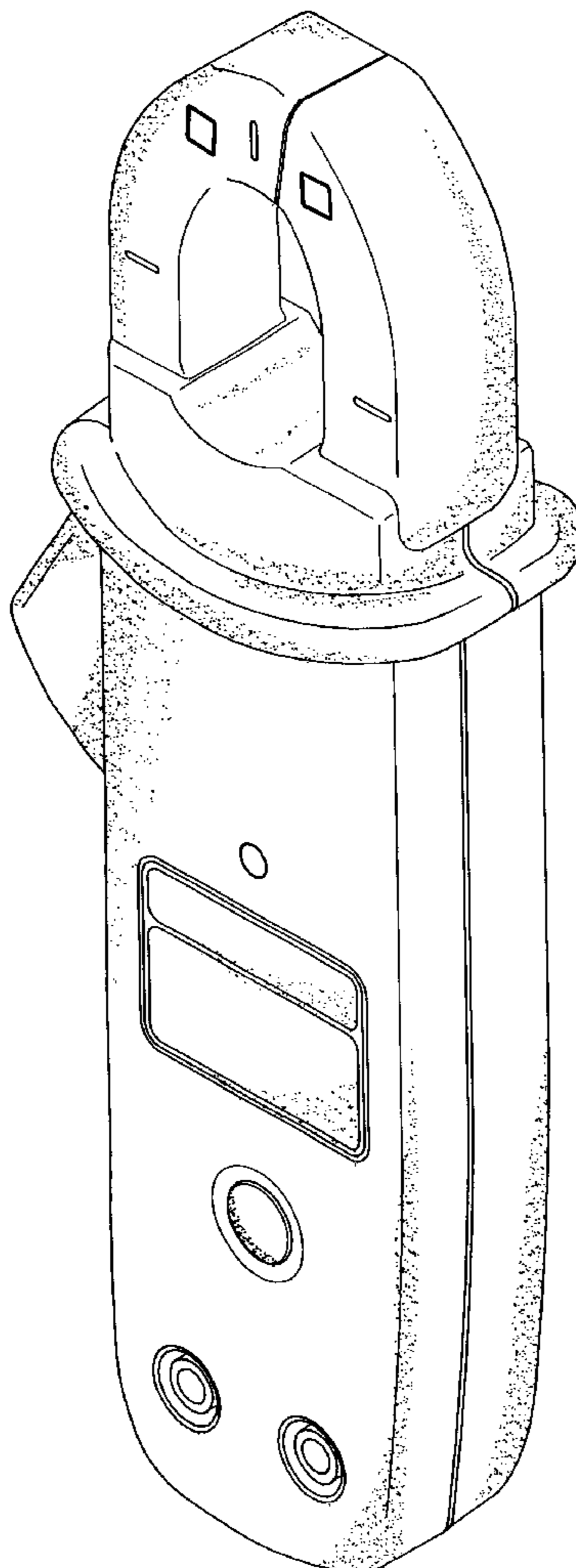
(57) **CLAIM**

The ornamental design for a clamp multimeter, as shown and described.

DESCRIPTION

FIG. 1 is a perspective view of the clamp multimeter showing the new design;
FIG. 2 is a front view of the new design;
FIG. 3 is a rear view of the new design;
FIG. 4 is a left view of the new design;
FIG. 5 is a right view of the new design;
FIG. 6 is a top view of the new design; and,
FIG. 7 is a bottom view of the new design.

1 Claim, 6 Drawing Sheets



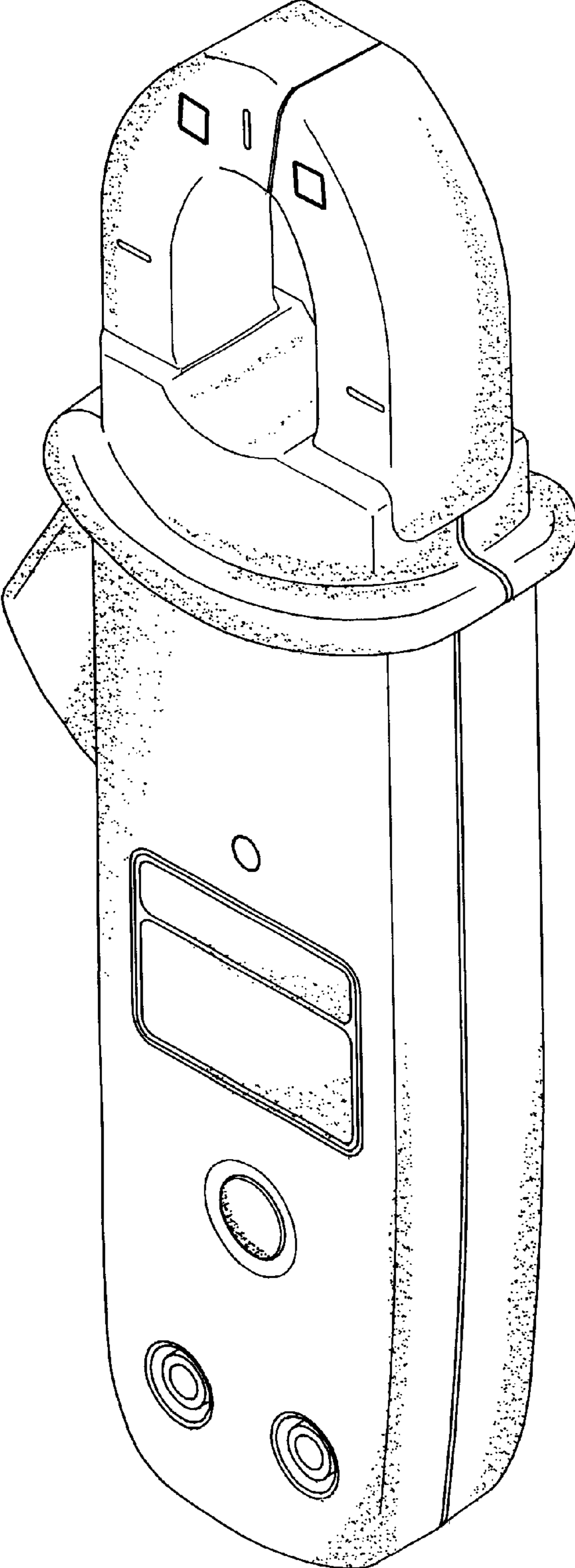


FIG. 1

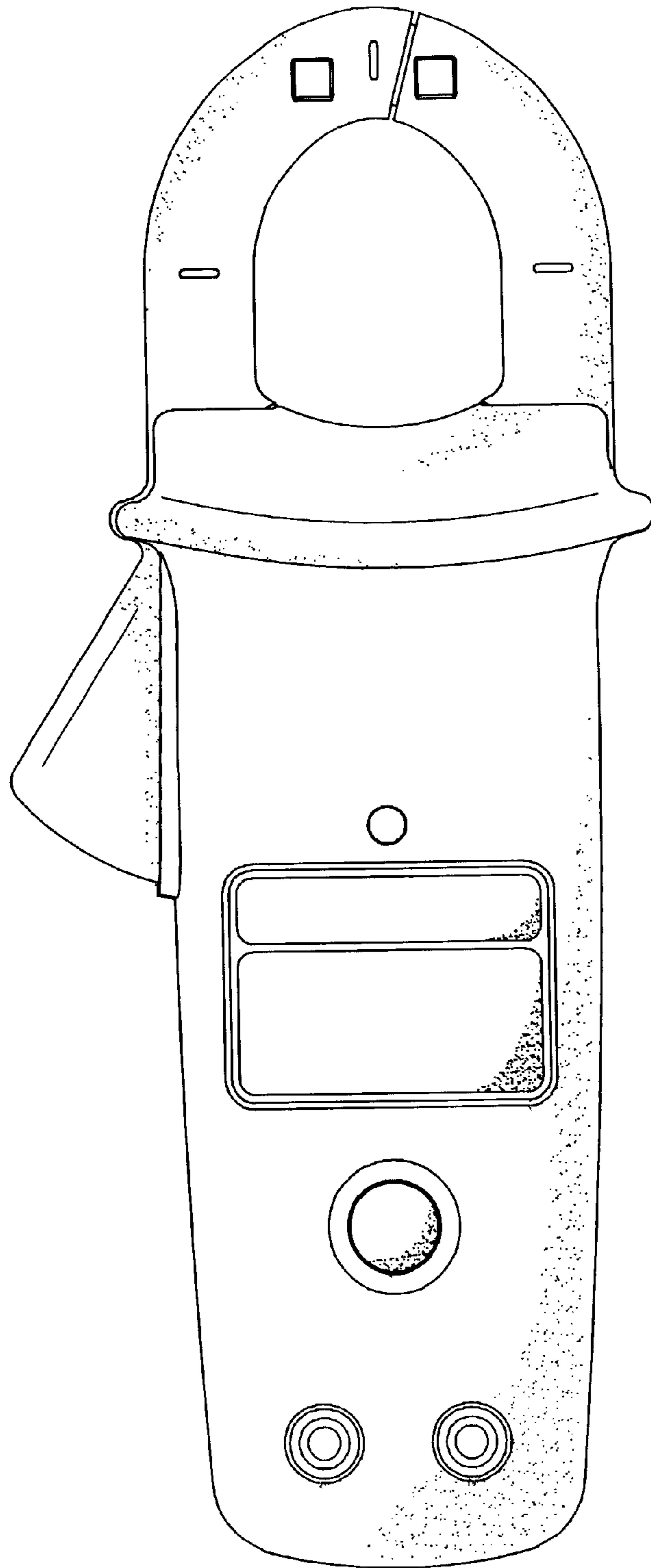


FIG. 2

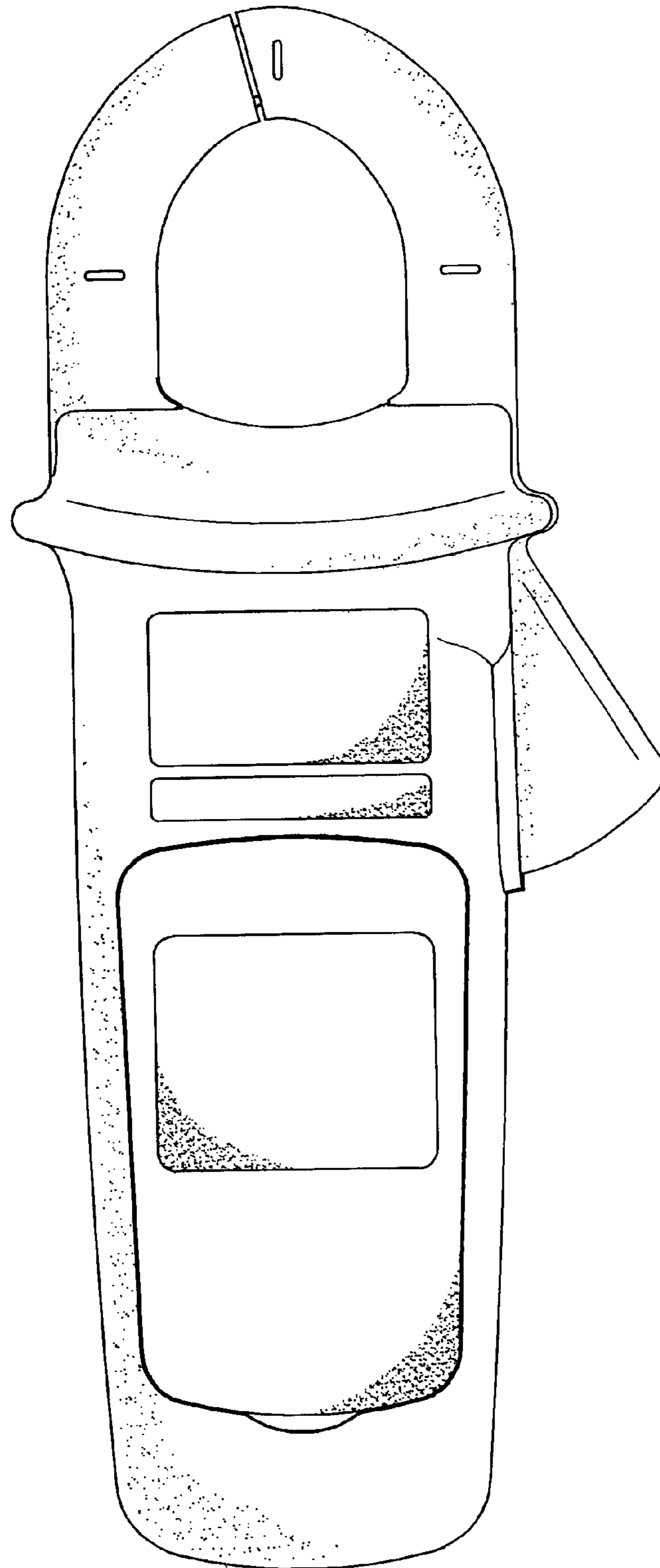


FIG. 3

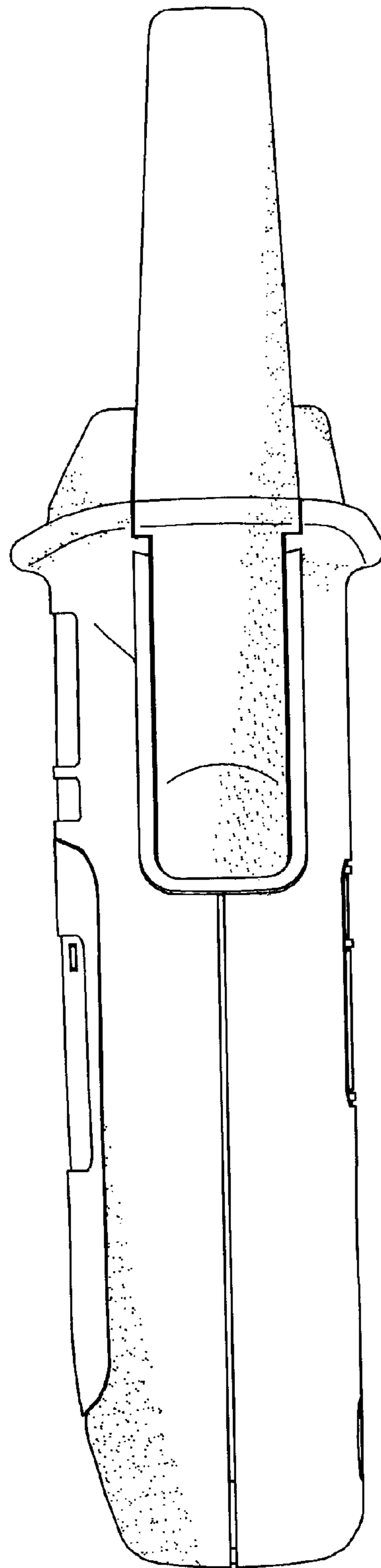


FIG. 4

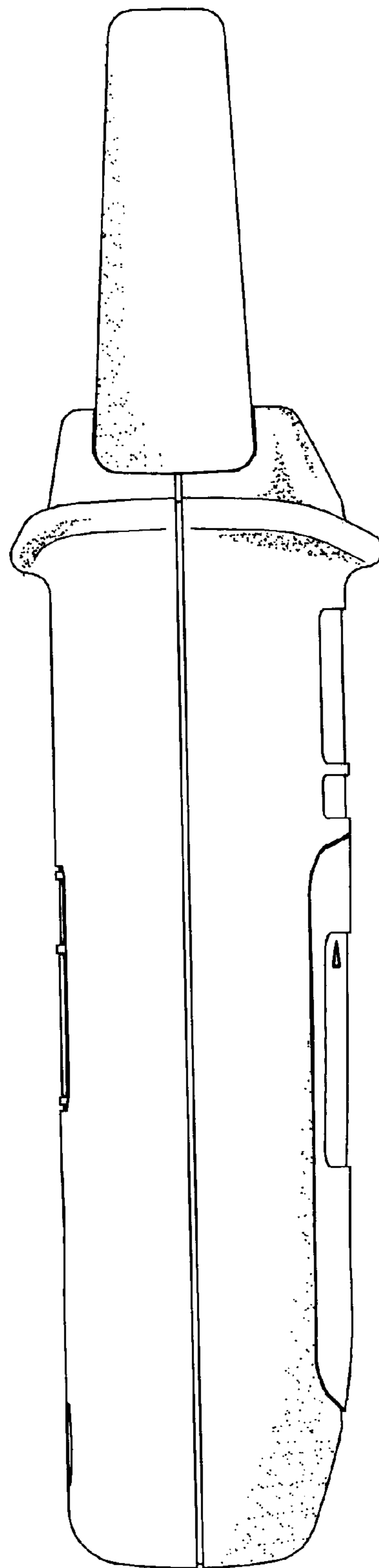


FIG. 5

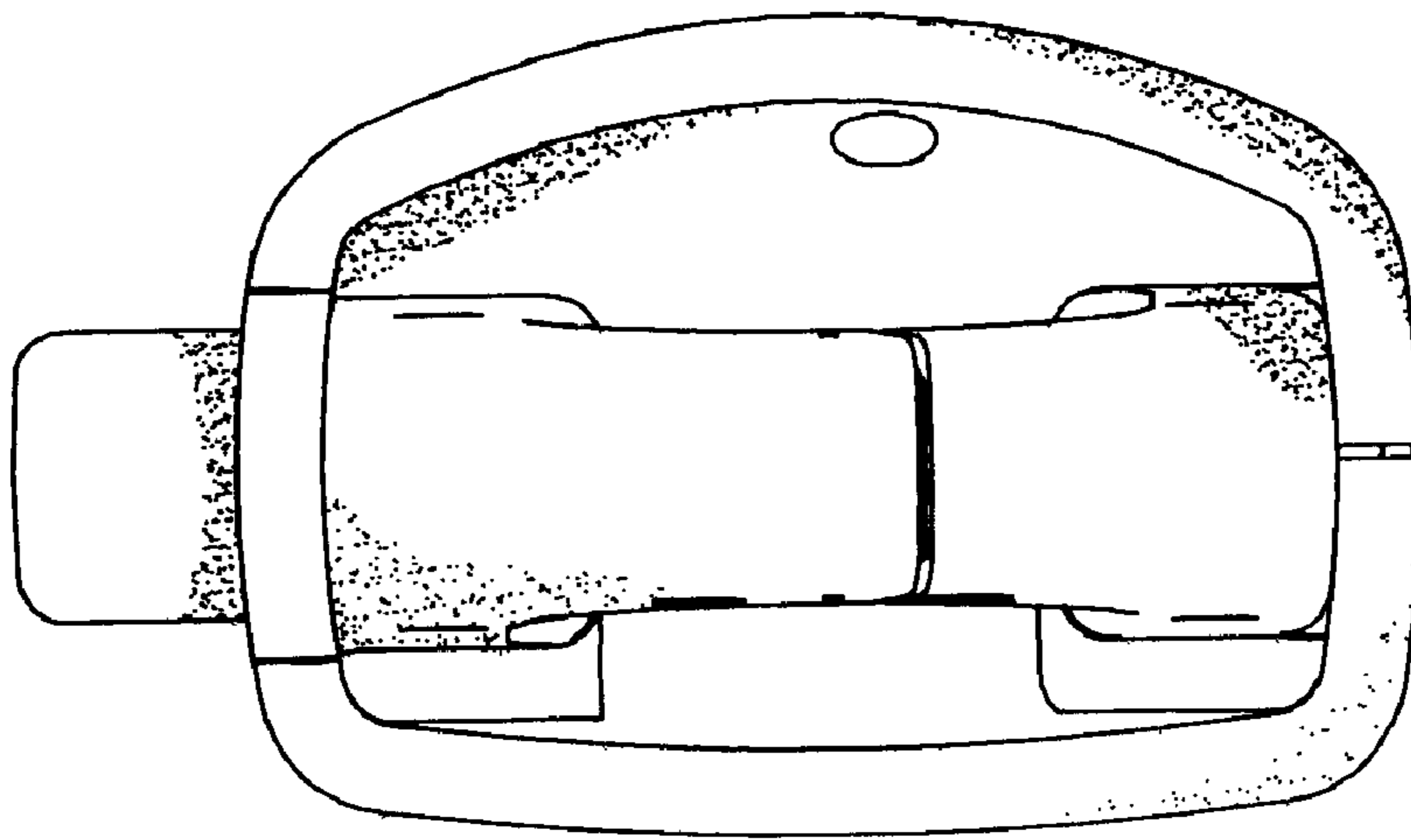


FIG. 6

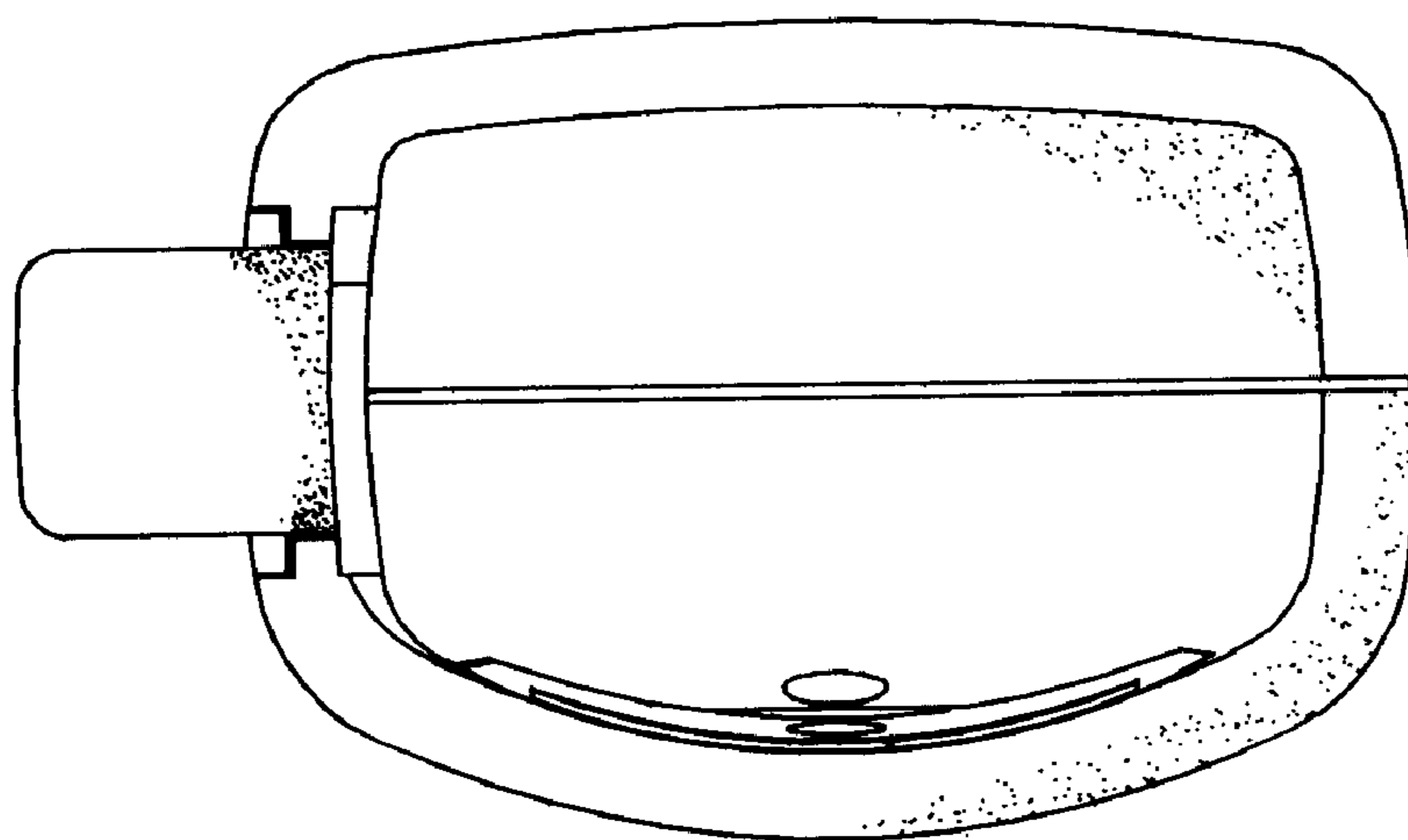


FIG. 7